# Periodic driving of e/3 and e/5 Anyons in the FQHE Regime

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# Motivation

#### PERIODIC DRIVING of a mesoscopic conductor

- Brings new information on electron time-scales: quantum inductance ~  $(h/e^2)\tau$ , quantum capacitance ~  $(e^2/h)\tau$ , charge relaxation (or Büttiker's) resistance  $h/2e^2$
- Can provide interesting comparison between quantum systems and cycle-operated thermodynamic engines ٠
- be simply described by the photo-absorption (i.e., For voltage pulses on a contact V(t)=V<sub>dc</sub> +V<sub>ac</sub>(t):  $p_l = \frac{1}{T} \int_0^T dt \ e^{-i\phi(t)} \ e^{il2\pi vt}$  Energy Can be simply described by the photo-absorption (I>0) or emission (I<0) Floquet probability  $P_1 = |p_1|^2$ ٠ (D)  $\rightarrow \varepsilon + 2hv$ eV<sub>dc</sub>= hv  $E_{F}$  $O^{P.A.}(V_{dc}) = P_0 O_{DC}(V_{dc}) + P_1 O_{DC}(V_{dc} + hv/q) + P_{-1} O_{DC}(V_{dc} - hv/q) +$  $\varepsilon - 2hv$  $+ P_2 O_{DC} (V_{dc} + 2hv/q) + \dots$  $\Delta I(t)$ V(t) O: current, heat, current noise, heat noise, ....
- An interesting regime is when the A.C. voltage amplitude is small, typically  $eV_{ac} \sim hv \rightarrow dv$ single-electron transport

Current

$$I(t) = v_F \left| \psi(t) \right|^2$$

Heat current

$$I^{Q}(t) = v_{F} \hbar \operatorname{Im}\left[\frac{d\psi(t)^{*}}{dt}\psi(t)\right]$$

M. Moskalets, G. Haack - physica status solidi (b), (2017) M.F. Ludovico, J. S. Lim, M. Moskalets, L. Arrachea, D. Sanchez (2014)





# coherent single electron sources



- simple: voltage pulse on a contact
- Lorentzian pulses create **minimal excitation states** (levitons)
- time resolved (no quantum jitter)
- long lifetime
- Minimal heat production: Dashti, Misiorny, Kheradsoud, Samuelsson, and Splettstoesser, PRB 100, 035405 (2019)

) Levitov, Lee,Lesovik, J. Math. Phys.(1996) Keeling, Klich and Levitov PRL 97, 116403 (2006)

## Periodic single electron sources



Periodic electron injection is well described by Photo-Assisted process

# **NEW Quantum physics with on-demand electrons**





(many particle HOM experiments open a new field of quantum investigations)

### **NEW Quantum physics with on-demand electrons**

Wigner Function of (periodic) levitons



# This TALK:

- First step to realize a single anyon source
- Shows that FQHE abelian anyons with charge e\*=e/3 and e/5 can be manipulated with microwave by well-defined Photon-Assisted processes.
- Validates the possibility to realize on-demand single anyon sources for time domain anyon braiding.
- Based on Photon-Assisted Shot Noise (PASN) measurements
- Photon-Assisted process revealed by the anyonic Josephson relation  $e^*V/h=f$ (X. G. Wen (1991))

### Anyons

$$\left|\psi(a,b)\right\rangle = e^{i\theta_{s}}\left|\psi(b,a)\right\rangle$$

(Leynaas+Mirrheim 1977, Wilczek 1982)

expected for Fractional Quantum Hall effect (FQHE) quasiparticles (Arovas, Schrieffer, Wilczek 1984)

<u>Example</u>: for filling factor v = 1/3 ( = 1 electron/3 quantum states)

a quasi-hole particle has a charge  $e^{*}=-e/3$  (Laughlin 1983)



$$\Psi^{2-holes}(z_a, z_b) = \exp\left(i\frac{\pi}{3}\right)\Psi^{2-holes}(z_b, z_a)$$
Berry phase



### Anyons



To date: no convincing experimental observation of anyons

BRAIDING

### Our approach: Hong Ou Mandel Braiding Interference

Hong, Ou, & Mandel (1987)



### Hong Ou Mandel Braiding Interference



$$P(1,2) = (1 - g_2(\tau) \cos\theta_S)/2$$

### Hong Ou Mandel Braiding Interference



### OUTLINE

- EDGE STATE and DC SHOT NOISE in FQHE
- PHOTON-ASSISTED TRANSPORT
  - Photon-assisted processes
  - A JOSEPHSON Relation for Photon Assisted Shot Noise (PASN)
- Experimental Results
  - e\*=e/3
  - e\*=e/5
- CONCLUSION and PERSPECTIVES

## QHE and EDGE STATES



#### Integer Quantum Hall Effect (IQHE)

 $R_{hall} = (h/e^2)1/v \quad v = 1, 2, 3, ...$ 





$$R_{Hall} = \frac{B}{e n_s} = \frac{h}{e^2} \frac{1}{(\nu = k)}$$

### QHE and EDGE STATES



cyclotron motion drift  $\rightarrow$  chiral 1D EDGE CHANNELS



 $R_{hall} = (h/e^2)1/v \quad v=1,2,3,...$ 



Fractional Quantum Hall Effect (FQHE)

### Tunneling through a v=2/5 Jain FQHE state



J. K. Jain Composite-fermion approach for the fractional quantum Hall effect. Phys. Rev. Lett. 63, 199-202 (1989)

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  - Photon-assisted processes
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### DC SHOT NOISE (weak coupling)



### Photon-Assisted Shot Noise (PASN)

 $P_l$ : probability to absorb (emit) l > 0 (<0) Photons



### Photon-Assisted Shot Noise (PASN)

 $V(t)=V_{dc} + V_{ac}\cos(2\pi f t)$   $P_l$ : probability to absorb (emit) l > 0 (<0) Photons











### Experimental Set-up and samples

Samples:  $n_s = 1.07 \ 10^{11} \ cm^{-2} \ \mu = 3 \ 10^6 \ cm^2 V^{-1} s^{-1}$  (from I. Farrer, D. Ritchie, Cambridge UK)



### **Experimental Set-up and samples**



Helium-free Cryoconcept® crysostat



**14 Tes**la Dry Magnet**13mK** base temperature

# DC Shot noise for the 1/3-FQHE state



## Photon-Assisted Shot Noise for the 1/3-FQHE state



## Photon-Assisted Shot Noise for the 1/3-FQHE state



### Photon-Assisted Shot Noise for the 1/3-FQHE state



f=22GHz

### Killing the non photon-assisted part !

**Excess PASN:** 

$$\Delta S_{I} = S_{I}^{PASN}(V_{dc}) - P_{0} S_{I}^{DC}(V_{dc})$$
  
=  $P_{1} \left[ S_{I}^{DC}(V_{dc} - hf / e^{*}) + S_{I}^{DC}(V_{dc} + hf / e^{*}) \right]$ 





Finding a flat variation for the low  $|V_{dc}|$  range provides a determination of  $P_0$ 



### Killing the non photon-assisted part !

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Finding a flat variation for the low  $|V_{dc}|$  range provides a determination of  $|p_0|^2$ 

as:  $P_0 + 2 P_1 \approx 1$ , this gives  $P_1$ 

### Killing the non photon-assisted part !

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---comparison using f<sub>Josephson</sub>=e\*V<sub>dc</sub>/h with e\*=e/3

# New Measurement of e\* for the 1/3-FQHE State

MEASURING e\* from Excess PASN:

 $\Delta S_{I} = S_{I}^{PASN} (V_{dc}) - P_{0} S_{I}^{DC} (V_{dc})$ =  $P_{1} \left[ S_{I}^{DC} (V_{dc} - hf / e^{*}) + S_{I}^{DC} (V_{dc} + hf / e^{*}) \right]$  M. Kapfer et al. SCIENCE, Vol. 363 pp. 846-849 (2019)

threshold voltage :  $V_J = hf/e^*$  scales with frequency!

Best fit of data with e\* free parameter





# DC Shot noise for the 2/5-FQHE state



![](_page_34_Figure_2.jpeg)

![](_page_34_Figure_3.jpeg)

$$S_{I}^{DC} = 2e * I_{B} \left[ \operatorname{coth} \left( \frac{e * V_{dc}}{2k_{B}T} \right) - \frac{2k_{B}T}{e * V_{dc}} \right] \propto - \langle \Delta I_{B} \Delta I_{t} \rangle$$
  
e\*= e/5 !

confirms Weizmann results (Reznikov 1999) on 2/5

### New Measurement of e\* for the 2/5-FQHE State

#### MEASURING e\* from Excess PASN:

$$\Delta S_{I} = S_{I}^{PASN}(V_{dc}) - P_{0} S_{I}^{DC}(V_{dc})$$
  
=  $P_{1} \left[ S_{I}^{DC}(V_{dc} - hf / e^{*}) + S_{I}^{DC}(V_{dc} + hf / e^{*}) \right]$ 

threshold voltage :  $V_J = hf/e^*$  scales with frequency!

Best fit of data with e\* free parameter

![](_page_35_Figure_5.jpeg)

![](_page_35_Figure_6.jpeg)

M. Kapfer et al. SCIENCE, Vol. 363 pp. 846-849 (2019)

# CONCLUSION

![](_page_36_Figure_1.jpeg)

- WE HAVE SHOWN the MICROWAVE CONTROL of ANYONS is possible
- NEXT STEP : sine-wave to Lorentzian pulses.
- → TIME RESOLVED STOCHASTIC SOURCE OF ANYONS

See: theory prediction for photo-assisted current noise at v=1/3 J. Rech, D. Ferraro, T. Jonckheere, L. Vannucci, M. Sassetti, and T. Martin, . Phys. Rev. Lett. 118, 076801 (2017)

Also heat noise at at v=1/3

L. Vanucci; F. Ronetti, J. Rech, D. Ferraro, T. Jonckheere, T. Martin, M. Sassetti, PRB 95, 245415 (2017)

![](_page_36_Figure_8.jpeg)

### PERSPECTIVE : ANYON BRAIDING INTERFERENCE

![](_page_37_Figure_1.jpeg)

 $-\langle \Delta I_u \Delta I_d \rangle \propto 1 + g_2(\tau) \cos(\theta_{stat.})$ 

A DC version can be find in: ``*Current Correlations from a Mesoscopic* Anyon Collider " B. Rosenow, I. P. Levkivskyi, B. I. Halperin, (2016)

### **CONCLUSION-2**

**SHOT NOISE** combined with Microwave **PHOTONS** 

ightarrow 2 ways to determine carrier charge

![](_page_38_Figure_3.jpeg)

e/3 and e/5: M. Kapfer et al. SCIENCE, Vol. 363 pp. 846-849 (2019) e/3 finite frequency noise, R. Bisognin et al. Nature Communications (2019)

### ACKNOWLEDGEMENTS

![](_page_39_Figure_1.jpeg)

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M. Freedman

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![](_page_39_Picture_9.jpeg)

*The Josephson Frequency of fractionally charge anyons* **M. Kapfer**, P. Roulleau, I. Farrer, D. A. Ritchie, and D. C. Glattli, **SCIENCE**, Vol. 363 pp. 846-849 (2019)

*Levitons :* J. Dubois et al**, Nature** 502, 659 (2013) T. Jullien et al**., Nature** 514, 603 (2014) OPEN POSITION for 18-24 months Post-doct.

# CONCLUSION

![](_page_41_Figure_1.jpeg)

- WE HAVE SHOWN the MICROWAVE CONTROL of ANYONS is possible
- NEXT STEP : sine-wave to Lorentzian pulses.
- → TIME RESOLVED STOCHASTIC SOURCE OF ANYONS

Why only charge e levitons in FQHE.

1e<sup>-</sup> 1e<sup>-</sup> ...

$$\Delta \phi = \frac{1}{\hbar} \int e^* V(t) dt = 2\pi$$
$$I(t) = e^* \frac{e}{h} V(t)$$

$$\int I(t)dt = e$$

See: also: Jérome Rech's Talk, Wednesday Session 3-C, and J. Rech, D. Ferraro, T. Jonckheere, L. Vannucci, M. Sassetti, and T. Martin, . Phys. Rev. Lett. 118, 076801 (2017)

![](_page_41_Figure_9.jpeg)

### DC SHOT NOISE: Integer QHE

![](_page_42_Figure_1.jpeg)

![](_page_43_Figure_0.jpeg)

(X.G. Wen 1995, C. Kane + M. Fisher 1994; Fendley, Ludwig + Saleur (1995))

### A Josephson relation for fractionally charged anyons

#### M. Kapfer<sup>1</sup>, P. Roulleau<sup>1</sup>, M. Santin<sup>1</sup>, I. Farrer<sup>2</sup>, D. A. Ritchie<sup>3</sup>, D. C. Glattli<sup>1\*</sup>

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![](_page_44_Figure_7.jpeg)

![](_page_44_Picture_8.jpeg)

![](_page_44_Picture_9.jpeg)

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![](_page_45_Figure_6.jpeg)

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![](_page_46_Figure_6.jpeg)

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![](_page_47_Figure_6.jpeg)

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![](_page_48_Figure_6.jpeg)

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![](_page_49_Figure_6.jpeg)

![](_page_50_Figure_1.jpeg)

![](_page_51_Figure_1.jpeg)

![](_page_52_Figure_1.jpeg)

![](_page_53_Figure_1.jpeg)

![](_page_54_Figure_1.jpeg)

![](_page_55_Figure_1.jpeg)